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SEMICONDUCTOR TM

## FQB70N10 / FQI70N10 **100V N-Channel MOSFET**

## **General Description**

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for low voltage applications such as audio amplifier, high efficiency switching DC/DC converters, and DC motor control.

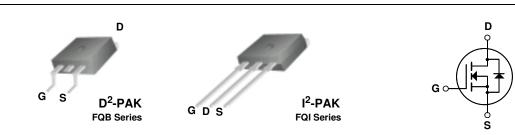
## **Features**

\* 57A, 100V,  $R_{DS(on)} = 0.023\Omega @V_{GS} = 10 V$ \* Low gate charge ( typical 85 nC)

August 2000

ТΜ

- Low Crss (typical 150 pF) •
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability
- 175°C maximum junction temperature rating



## Absolute Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted

Symbol	Parameter		FQB70N10 / FQI70N10	Units
V <sub>DSS</sub>	Drain-Source Voltage		100	V
I <sub>D</sub>	Drain Current - Continuous (T <sub>C</sub> = 25°C) - Continuous (T <sub>C</sub> = 100°C)		57	А
			40.3	А
I <sub>DM</sub>	Drain Current - Pulsed	(Note 1)	228	А
V <sub>GSS</sub>	Gate-Source Voltage		± 25	V
E <sub>AS</sub>	Single Pulsed Avalanche Energy (Note 2)		1300	mJ
I <sub>AR</sub>	Avalanche Current (Note 1)		57	А
E <sub>AR</sub>	Repetitive Avalanche Energy	(Note 1)	16	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)		6.0	V/ns
P <sub>D</sub>	Power Dissipation $(T_A = 25^{\circ}C)^{*}$		3.75	W
	Power Dissipation $(T_C = 25^{\circ}C)$		160	W
- Derate above 25°C			1.06	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to +175	°C
TL	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

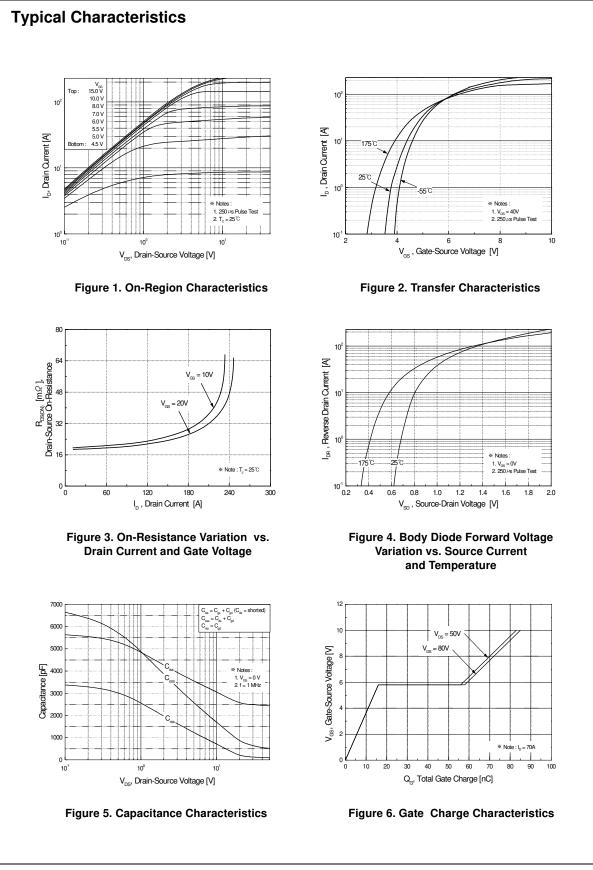
## **Thermal Characteristics**

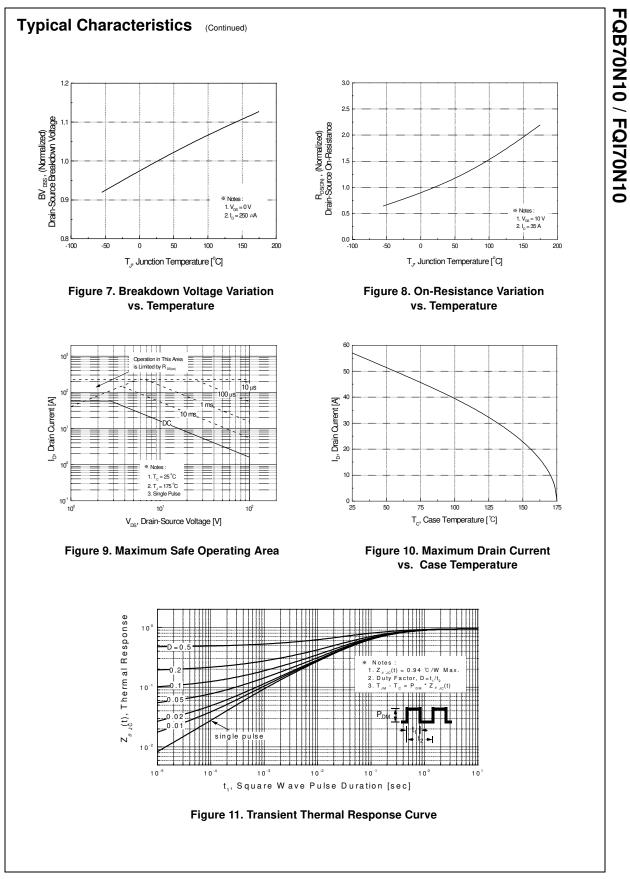
Symbol	Parameter	Тур	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		0.94	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient *		40	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		62.5	°C/W

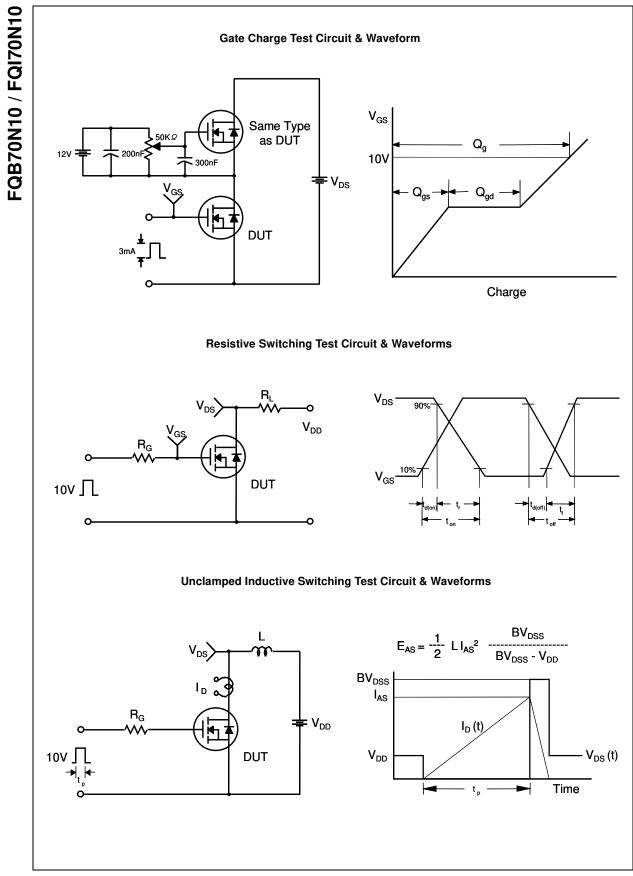
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Off Cha	Parameter	Test Conditions	Mi	Тур	Max	Units
	aracteristics					
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA	10			V
ΔBV <sub>DSS</sub> ΔΤ <sub>J</sub>	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}$ , Referenced to 25°C		0.1		V/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 0 V			1	μA
		$V_{DS} = 80 \text{ V}, \text{ T}_{C} = 150^{\circ}\text{C}$			10	μA
GSSF	Gate-Body Leakage Current, Forward	$V_{GS} = 25 V, V_{DS} = 0 V$			100	nA
GSSR	Gate-Body Leakage Current, Reverse	$V_{GS} = -25 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$			-100	nA
On Cha	aracteristics					
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μA	2.0		4.0	V
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 28.5 \text{ A}$		0.019	0.023	Ω
9FS	Forward Transconductance	V <sub>DS</sub> = 40 V, I <sub>D</sub> = 28.5 A (Note	4)	45		S
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub>	Input Capacitance Output Capacitance Reverse Transfer Capacitance	V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V, f = 1.0 MHz		2500 720 150	3300 940 200	pF pF pF
	ing Characteristics	r			1	
Switch	Turn-On Delay Time	V <sub>DD</sub> = 50 V, I <sub>D</sub> = 70 A,		30	70	ns
<b>Switchi</b> d(on) r	Turn-On Delay Time Turn-On Rise Time	$V_{DD}$ = 50 V, I <sub>D</sub> = 70 A, R <sub>G</sub> = 25 Ω		470	950	ns ns
Switchi d(on) r d(off)	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time	$R_{G} = 25 \Omega$		470 130	950 270	
Switchi d(on) r d(off) f	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time			470 130 160	950 270 330	ns ns ns
Switchi d(on) r d(off) f Qg	Turn-On Delay Time         Turn-On Rise Time         Turn-Off Delay Time         Turn-Off Fall Time         Total Gate Charge	$R_{G} = 25 \Omega$		470 130 160 85	950 270 330 110	ns ns ns nC
Switchi td(on) tr td(off) tf Qg Qgs	Turn-On Delay Time         Turn-On Rise Time         Turn-Off Delay Time         Turn-Off Fall Time         Total Gate Charge         Gate-Source Charge	$R_{G} = 25 \Omega$ (Note 4 V <sub>DS</sub> = 80 V, I <sub>D</sub> = 70 A, V <sub>GS</sub> = 10 V	, 5) 	470 130 160 85 16	950 270 330 110 	ns ns nS nC nC
Switchi d(on) r d(off) f Qg Qgs	Turn-On Delay Time         Turn-On Rise Time         Turn-Off Delay Time         Turn-Off Fall Time         Total Gate Charge	$R_{G} = 25 $ Ω (Note 4 $V_{DS} = 80 $ V, $I_{D} = 70 $ A,	, 5) 	470 130 160 85	950 270 330 110	ns ns ns nC
Switchi td(on) tr td(off) tf Qg Qg Qgd	Turn-On Delay Time         Turn-On Rise Time         Turn-Off Delay Time         Turn-Off Fall Time         Total Gate Charge         Gate-Source Charge	$R_{G} = 25 \Omega$ (Note 4 V <sub>DS</sub> = 80 V, I <sub>D</sub> = 70 A, V <sub>GS</sub> = 10 V (Note 4	, 5) 	470 130 160 85 16	950 270 330 110 	ns ns ns nC nC
Switchi d(on) r d(off) f Qg Qgs Qgd	Turn-On Delay Time         Turn-On Rise Time         Turn-Off Delay Time         Turn-Off Fall Time         Total Gate Charge         Gate-Source Charge         Gate-Drain Charge	$R_{G}$ = 25 Ω (Note 4 $V_{DS}$ = 80 V, $I_{D}$ = 70 A, $V_{GS}$ = 10 V (Note 4 the Maximum Ratings	, 5) 	470 130 160 85 16	950 270 330 110 	ns ns ns nC nC
Switchi d(on) r d(off) f Qg Qgs Qgd Drain-S s SM	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge <b>Source Diode Characteristics al</b> Maximum Continuous Drain-Source Diode F	$R_{G} = 25 \ \Omega$ (Note 4 $V_{DS} = 80 \ V, \ I_{D} = 70 \ A,$ $V_{GS} = 10 \ V$ (Note 4 <b>Ind Maximum Ratings</b> ide Forward Current Forward Current	, 5) , 5) , 5)	470 130 160 85 16 42	950 270 330 110  	ns ns nC nC nC
Switchi d(on) r d(off) f Qg Qgs Qgs Qgd Drain-S s SM	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge <b>Source Diode Characteristics al</b> Maximum Continuous Drain-Source Diode F	$R_G = 25 \Omega$ (Note 4 V <sub>DS</sub> = 80 V, I <sub>D</sub> = 70 A, V <sub>GS</sub> = 10 V (Note 4 od Maximum Ratings ode Forward Current	     5)	470 130 160 85 16 42	950 270 330 110   57	ns ns nC nC nC
Switchi d(on) r d(off) f Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub> Drain-S	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge <b>Source Diode Characteristics al</b> Maximum Continuous Drain-Source Diode F	$R_{G} = 25 \ \Omega$ (Note 4 $V_{DS} = 80 \ V, \ I_{D} = 70 \ A,$ $V_{GS} = 10 \ V$ (Note 4 <b>Ind Maximum Ratings</b> ide Forward Current Forward Current	         	470 130 160 85 16 42	950 270 330 110  57 228	ns ns nC nC nC

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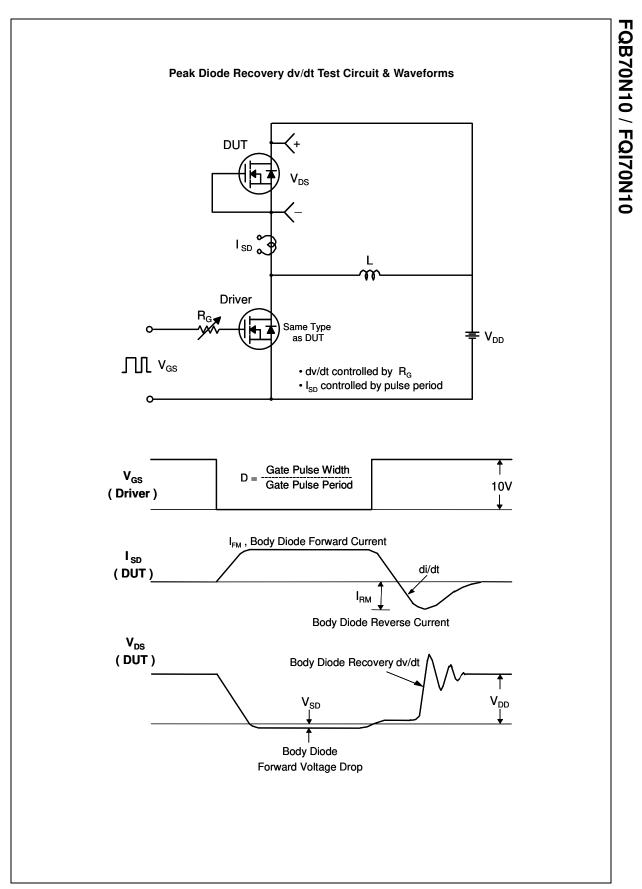






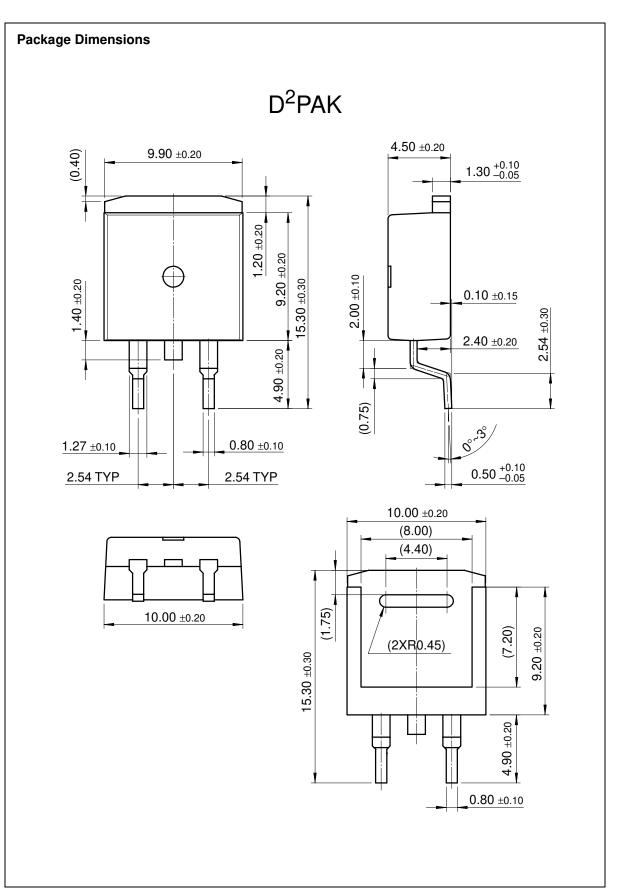
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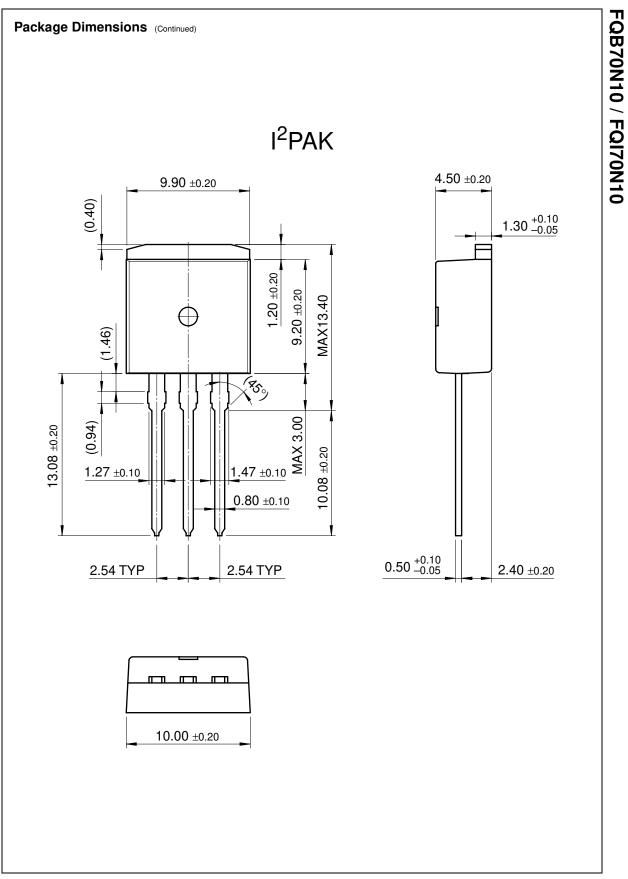
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